PATENT

Attorney Docket No.: 017032-000511US



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

WILLIAM K. WARBURTON et al.

Application No.: 10/690,470

Filed: October 20, 2003

For: METHOD AND APPARATUS FOR IMPROVING RESOLUTION IN SPECTROMETERS PROCESSING OUTPUT STEPS FROM NON-IDEAL SIGNAL SOURCES

Examiner: Unassigned

Art Unit: 2857

INFORMATION DISCLOSURE

STATEMENT UNDER 37 CFR §1.97 and §1.98

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Date Submitted: April 19, 2004

Sir:

The references cited on attached form PTO/SB/08B are being called to the attention of the Examiner. The above-referenced application is a continuation-in-part of U.S. Patent App. No. 10/429,170, filed May 1, 2003, (Attorney Docket No. 017032-000520US) which is a continuation of U.S. Patent App. No. 09/643,705, now U.S. Patent No. 6,587,814 (Attorney Docket No. 017032-000510US). Applicants are providing copies of publications 22 through 31 for the Examiner's convenience. At the Examiner's request, Applicants will gladly supply copies of the U.S. patent references.

It is respectfully requested that the cited references be expressly considered during the prosecution of this application, and the references be made of record therein and appear among the "references cited" on any patent to issue therefrom.

As provided for by 37 CFR 1.97(g) and (h), no inference should be made that the information and references cited are prior art merely because they are in this statement and no

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representation is being made that a search has been conducted or that this statement encompasses all the possible relevant information.

Respectfully submitted,

David N. Slone Reg. No. 28,572

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet	1 .	of	2

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			U.S. PATENT DO	OCUMENTS+		
Examiner Cite		Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where	
Initials*	No.1	Number Kind Code ² (if known)	MM-DD-YYYY	Applicant of Cited Document	Relevant Passages or Relevant Figures Appear	
	1	US-4,314,343	02/02/1982	Tomlinson		
	2	US-4,529,308	07/16/1985	Rife		
	3	US-4,554,633	11/19/1985	Glover et al.		
	4	US-4,727,256	02/23/1988	Kumazawa		
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	11	US-5,347,129	09/13/1994	Miller et al.		
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	13	US-5,684,850	11/04/1997	Warburton		
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	18	US-5,889,869	03/30/1999	Botros et al.		
	19	US-6,310,349	10/30/2001	Wong et al.		
	20	US-6,374,192	04/16/2002	Brogle et al.		
	21	US 6,587,814	07/01/2003	Warburton et al.		

FOREIGN PATENT DOCUMENTS								
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	22	JP	2000316072		11/14/2000	Kano et al.		

Examiner	Date	
Signature	Considered	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Applicant's unique citation designation number (optional). Applicant is to place a check mark here if English language Translation is attached.



INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Application Number 10/690,470 Filing Date October 20, 2003 First Named Inventor Warburton, William K. Art Unit 2857 Examiner Name Unassigned Attorney Docket Number 017032-000511US

Complete if Known

(use as many sheets as necessary)

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Sheet

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials *	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	Т:
*	23	Aalseth et al., "Using pulse shape discrimination to sort individual energy deposition events in a germanium crystal", Journal of Radioanalytical and Nuclear Chemistry, Vol.233, Nos 1-2 (1998) 119-123.	
	24	Goulding et al., "Ballistic Deficit Correction in Semiconductor Detector Spectrometers", I.E.E.E. Trans. Nuclear Science, Vol. 35, No. 1, (1988) 119-124.	
	25	Knoll, Glenn F., "Radiation Detection and Measurement, 2nd Ed." (J. Wiley, New York, 1989)	
	26	Radeka, V., "Trapezoidal Filtering of Signals from Large Germanium Detectors at High Rates", I.E.E.E. Trans. Nuclear Science, Vol. NS-19 (1982) 412-428.	
	27	Raudorf et al., "Pulse Shape and Risetime Distribution Calculations for HPGe Coaxial Detectors", I.E.E.E. Trans. Nuclear Science, Vol. NS-29, No. 1 (1982) 764-768.	
	28	Skulski et al., "Particle identification in CsI(TI) using digital pulse shape analysis," Nuclear Instruments and Methods in Physics Research, A458 (2001) 759-771	
	29	Stahle et al., "Design and performance of the Astro-E/XRF microcalorimeter array and anti- coincidence detector", in Proc. of the SPIE No. 3765, "EUV, X-ray and Gamma-ray Instrumentation for Astronomy X" (Denver, CO, July 21-23, 1999), in press.	
	30	Takahashi et al., "A Multiparametric Waveform Analysis of GE Detector Signal Based on Fast ADC Digitizing Technique", I.E.E.E. Trans. Nuclear Science, Vol. 41, No.4, (1994) 1246-1249.	
	31	White, G., "Pulse Processing for Gamma Ray Spectrometry: a Novel Method and its Implementation", I.E.E.E. Trans. Nuclear Science, Vol. 35, No. 1, (1988) 125-130.	

W. W. A. L.		
Examiner	Date	
Signature	Considered	

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